Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,111	TANAKA ET AL.	
Examiner	Art Unit	
J. Allen Shriver	3618	

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180	290	3/18/2006	JAS		
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	DATE	EXMR
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Checked for Double Patenting	3/18/2006	JAS